

Notice of References Cited	Application/Control No. 10/613,758	Applicant(s)/Patent Under Reexamination SCHMIDT ET AL.	
	Examiner Thien M. Le	Art Unit 2876	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,736,726	04-1998	VanHorn et al.	235/472.02
	B	US-2004/0178272	09-2004	Miyazawa et al.	235/462.43
	C	US-6,065,677	05-2000	Lippert et al.	235/462.43
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	E	US-4,968,883	11-1990	Leyshon et al.	250/239
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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